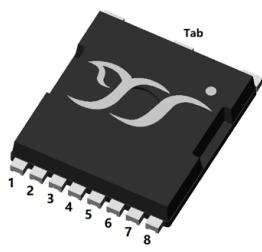




N-Channel Enhancement Mode Field Effect Transistor

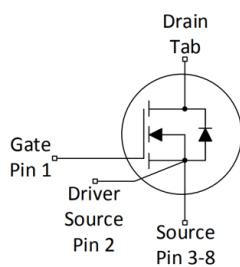


Top View



Bottom View

TOLL



Product Summary

- V_{DS} 600V
- I_D 33A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) $<72m\Omega$
- 100% EAS Tested
- 100% ∇V_{DS} Tested

General Description

- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- EV Charger
- AC-DC Power Management
- Server/Telecom/PC Power

Absolute Maximum Ratings ($T_J=25^\circ C$ unless otherwise noted)

Parameter			Symbol	Limit	Unit
Drain-source Voltage			V_{DS}	600	V
Gate-source Voltage			V_{GS}	± 30	V
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^\circ C, V_{GS}= 10V$	I_D	3.9	A
		$T_A=100^\circ C, V_{GS}= 10V$		2.4	
Continuous Drain Current (Note 1,3)	Steady-State	$T_C=25^\circ C, V_{GS}= 10V$		33	
		$T_C =100^\circ C, V_{GS}= 10V$		20	
Pulsed Drain Current	$T_C=25^\circ C, t_p=100\mu s$		I_{DM}	110	A
Avalanche energy	$V_G=10V, R_G=25\Omega, L=30mH, IAS=7.7A$		EAS	889.35	mJ
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^\circ C$	P_D	2.97	W
		$T_A=100^\circ C$		1.19	
Total Power Dissipation (Note 1,3)	Steady-State	$T_C=25^\circ C$		250	
		$T_C =100^\circ C$		100	
MOSFET dv/dt ruggedness	$V_{DS}=0...300V, R_g=12\Omega$		dv/dt	60	V/ns
Reverse diode dv/dt	$V_{DS}=0...300V, ID<=32A, di/dt=200A/us$		dv/dt	165	
Maximum diode commutation speed	$V_{DS}=0...300V, ID<=32A, R_g=12\Omega$		dif/dt	657	A/us
Junction and Storage Temperature Range			T_J, T_{STG}	-55~+150	°C

Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	Steady-State	$R_{\theta JA}$	35	42	°C/W
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	0.4	0.5	

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJT33C60HJ	F1	YJT33C60HJ	2000	4000	20000	13" reel



YJT33C60HJ

■ Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	600	-	-	V
		$V_{\text{GS}}=0\text{V}, I_{\text{D}}=10\text{mA}$	600	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=600\text{V}, V_{\text{GS}}=0\text{V}$	-	-	10	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	3	4	5	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=24\text{A}$	-	60	72	$\text{m}\Omega$
Diode Forward Voltage	V_{SD}	$I_{\text{S}}=24\text{A}, V_{\text{GS}}=0\text{V}$	-	-	1.2	V
Gate resistance	R_{G}	f=1MHz	-	2	-	Ω
Maximum Body-Diode Continuous Current	I_{S}		-	-	33	A
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{\text{DS}}=300\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	3480	-	pF
Output Capacitance	C_{oss}		-	108	-	
Reverse Transfer Capacitance	C_{rss}		-	22.4	-	
Effective output capacitance, energy related	$C_{\text{o(er)}}$	$V_{\text{DS}}=0\dots 300\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	160	-	
Effective output capacitance, time related	$C_{\text{o(tr)}}$		-	1000	-	
Switching Parameters						
Total Gate Charge	Q_{g}	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=300\text{V}, I_{\text{D}}=24\text{A}$	-	70	-	nC
Gate-Source Charge	Q_{gs}		-	21.8	-	
Gate-Drain Charge	Q_{gd}		-	29.6	-	
Reverse Recovery Charge	Q_{rr}	$I_{\text{F}}=24\text{A}, \text{di/dt}=100\text{A/us}$	-	1430	-	nC
Reverse Recovery Time	t_{rr}		-	157	-	ns
Peak reverse recovery current	I_{rrm}		-	17.4	-	A
Turn-on Delay Time	$t_{\text{D(on)}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DD}}=300\text{V}, I_{\text{D}}=24\text{A}$ $R_{\text{GEN}}=3\Omega$	-	64	-	ns
Turn-on Rise Time	t_{r}		-	18.5	-	
Turn-off Delay Time	$t_{\text{D(off)}}$		-	41.5	-	
Turn-off fall Time	t_{f}		-	6	-	

Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of R_{GJA} is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with TA =25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).

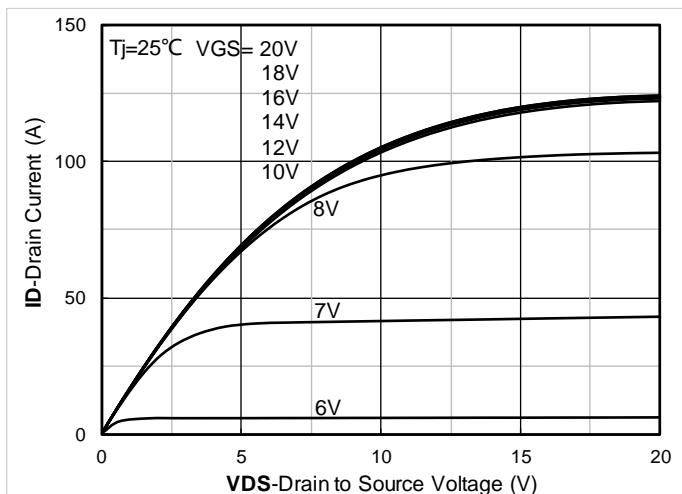
**■Typical Electrical and Thermal Characteristics Diagrams**

Figure 1. Output Characteristics

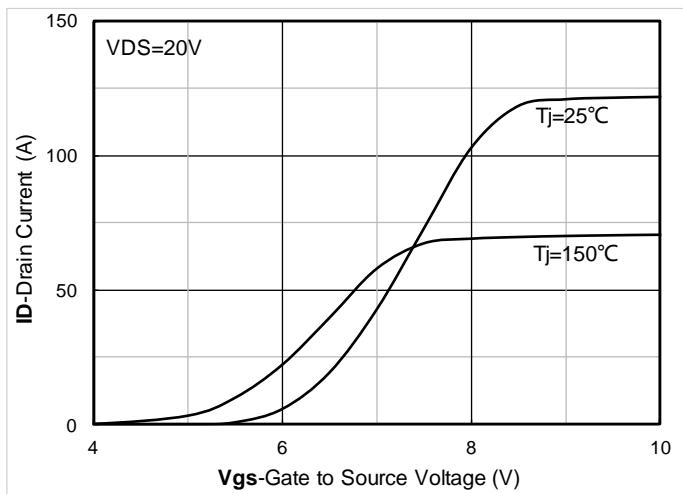


Figure 2. Transfer Characteristics

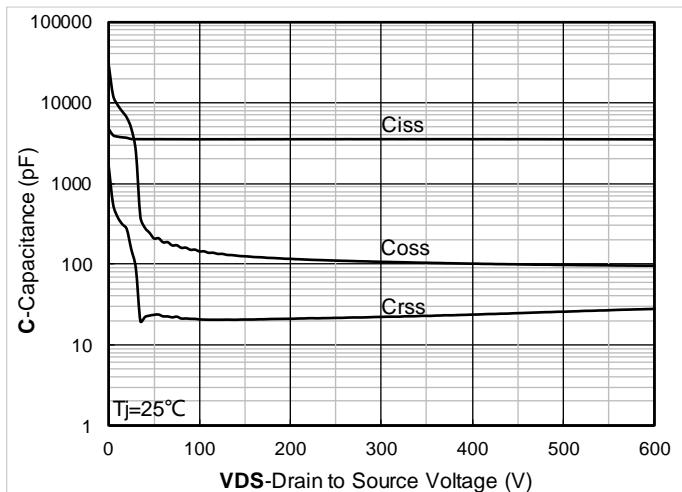


Figure 3. Capacitance Characteristics

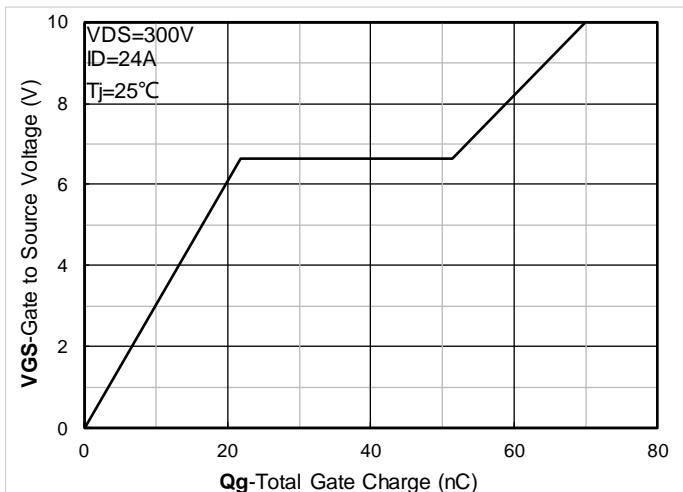


Figure 4. Gate Charge

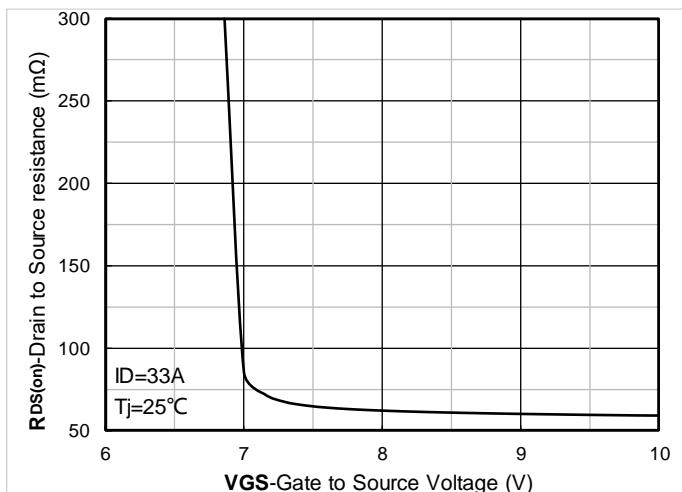


Figure 5. On-Resistance vs Gate to Source Voltage

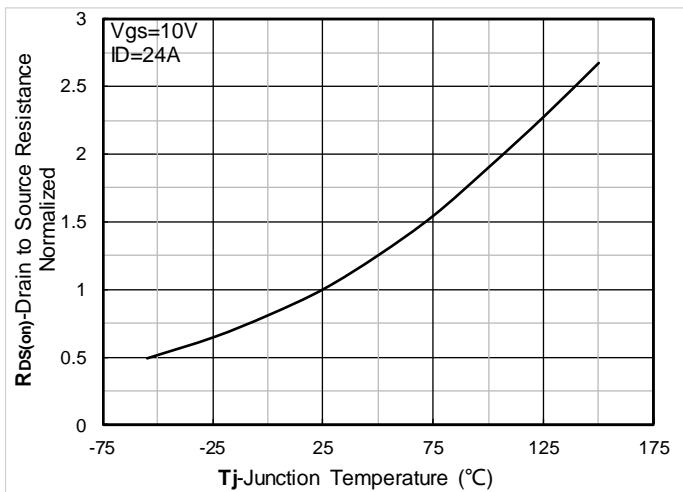


Figure 6. Normalized On-Resistance

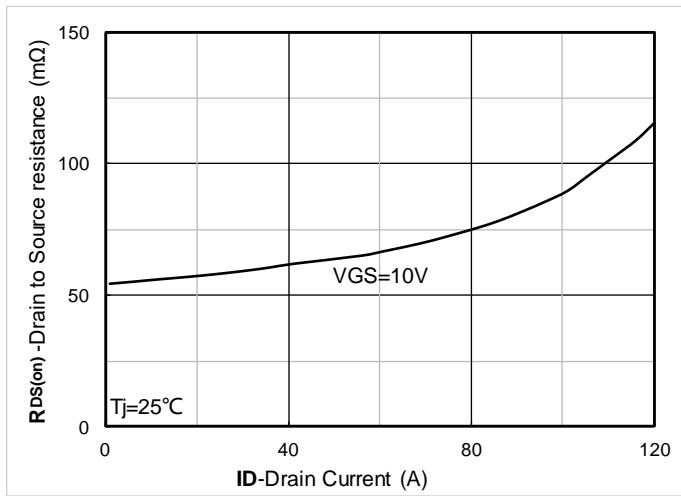


Figure 7. RDS(on) VS Drain Current

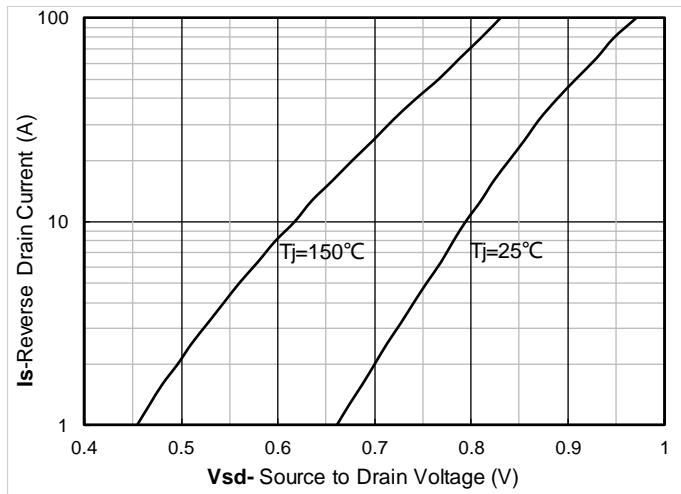


Figure 8. Forward characteristics of reverse diode

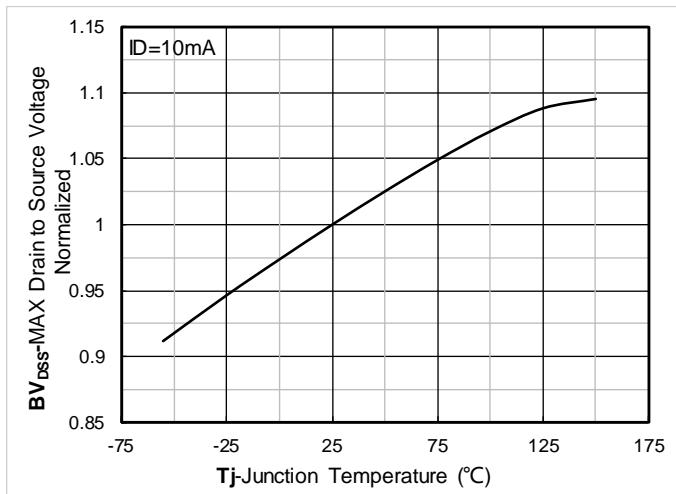


Figure 9. Normalized breakdown voltage

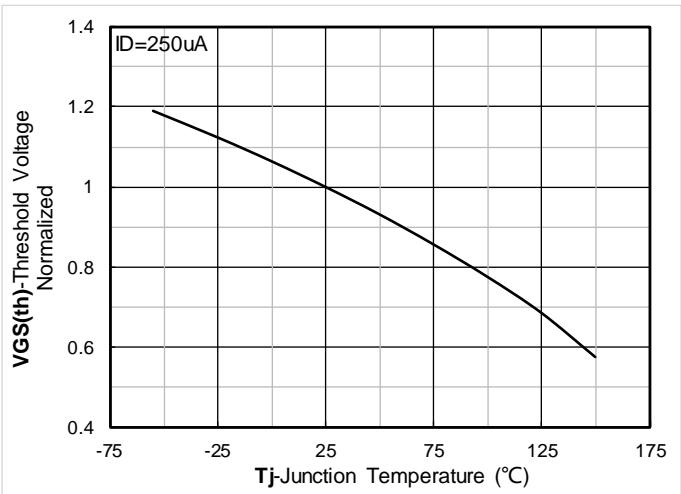


Figure 10. Normalized Threshold voltage

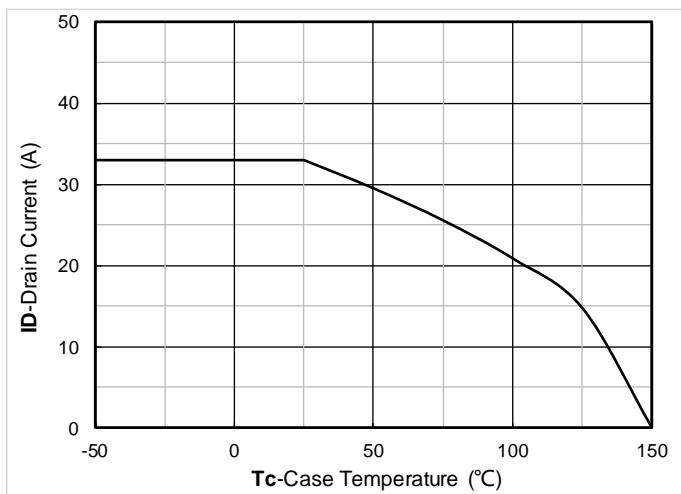


Figure 11. Current dissipation

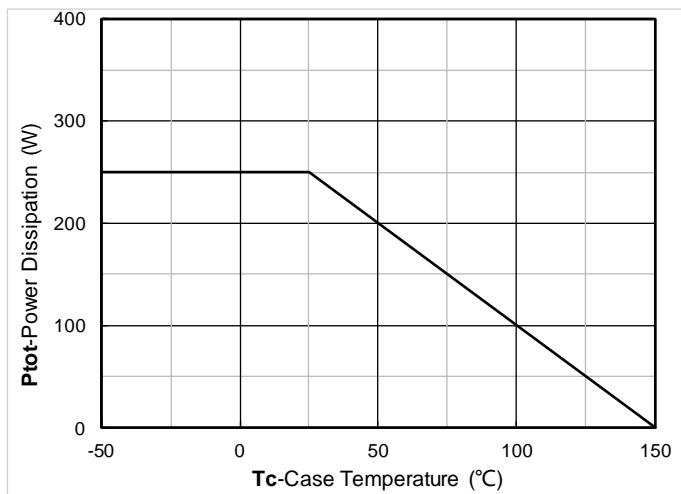


Figure 12. Power dissipation

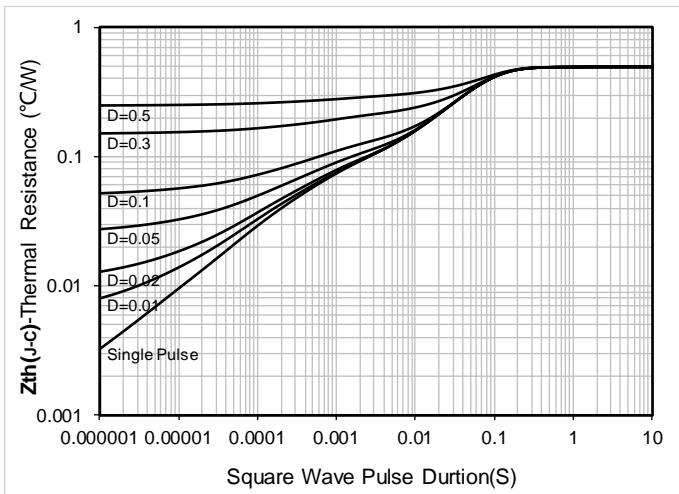


Figure 13. Maximum Transient Thermal Impedance

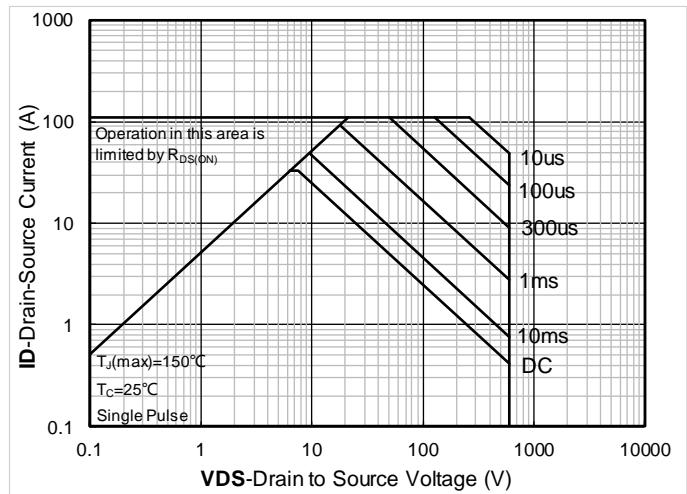


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

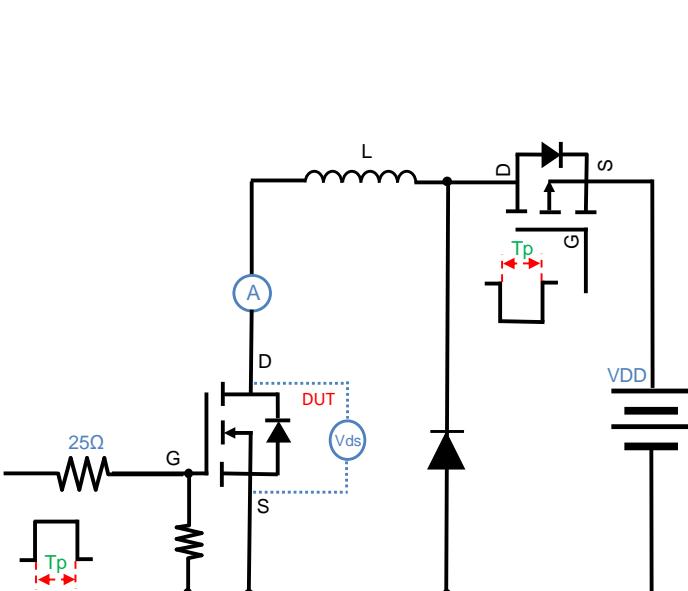


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

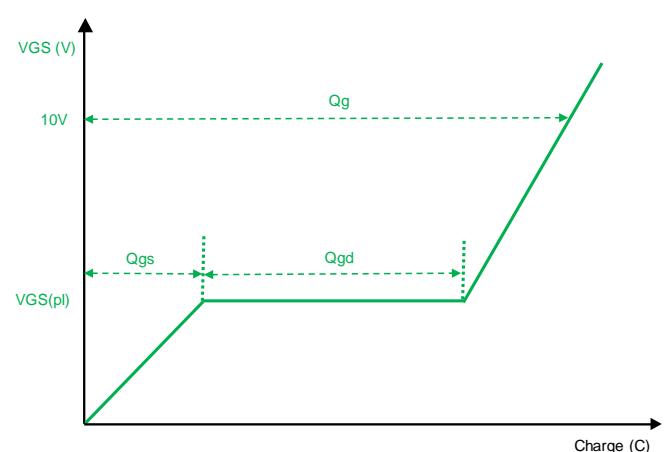
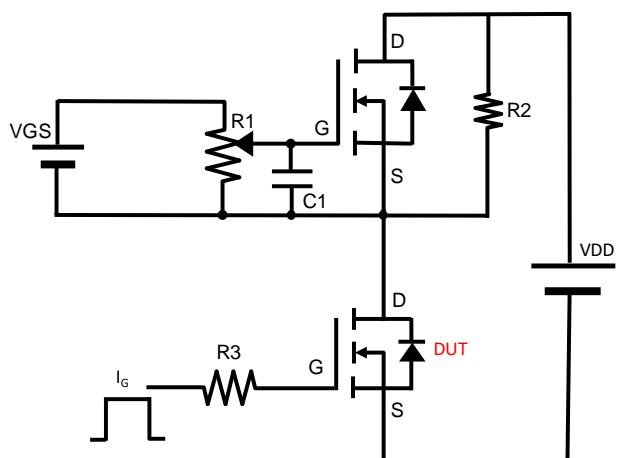


Figure B. Gate Charge Test Circuit & Waveform

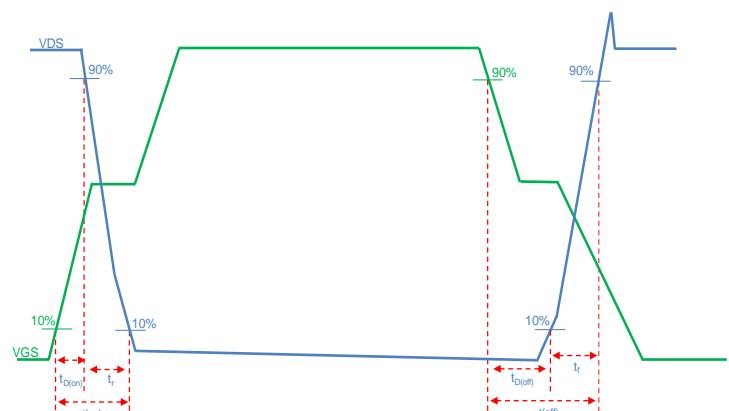
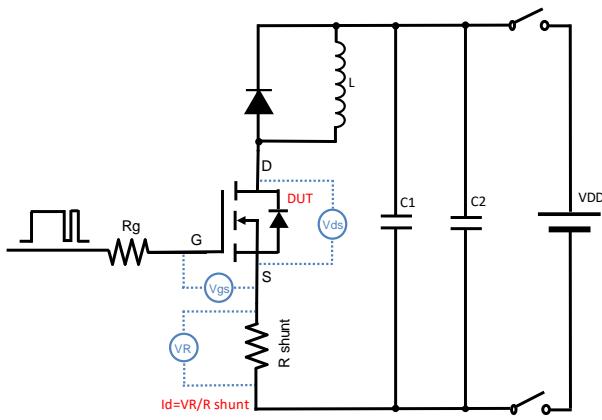


Figure C. Resistive Switching Test Circuit & Waveform

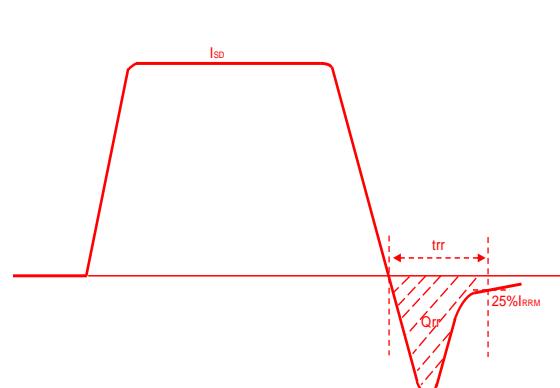
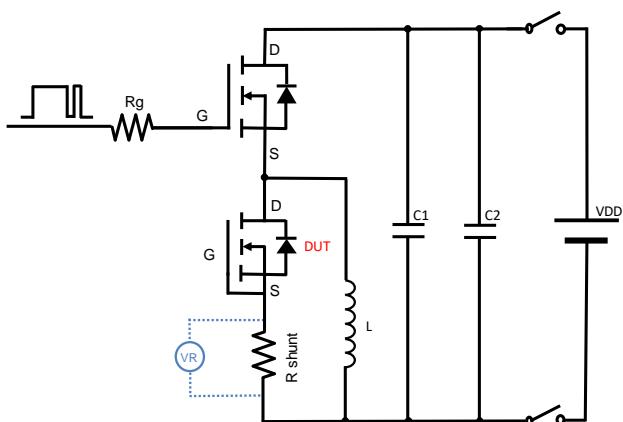
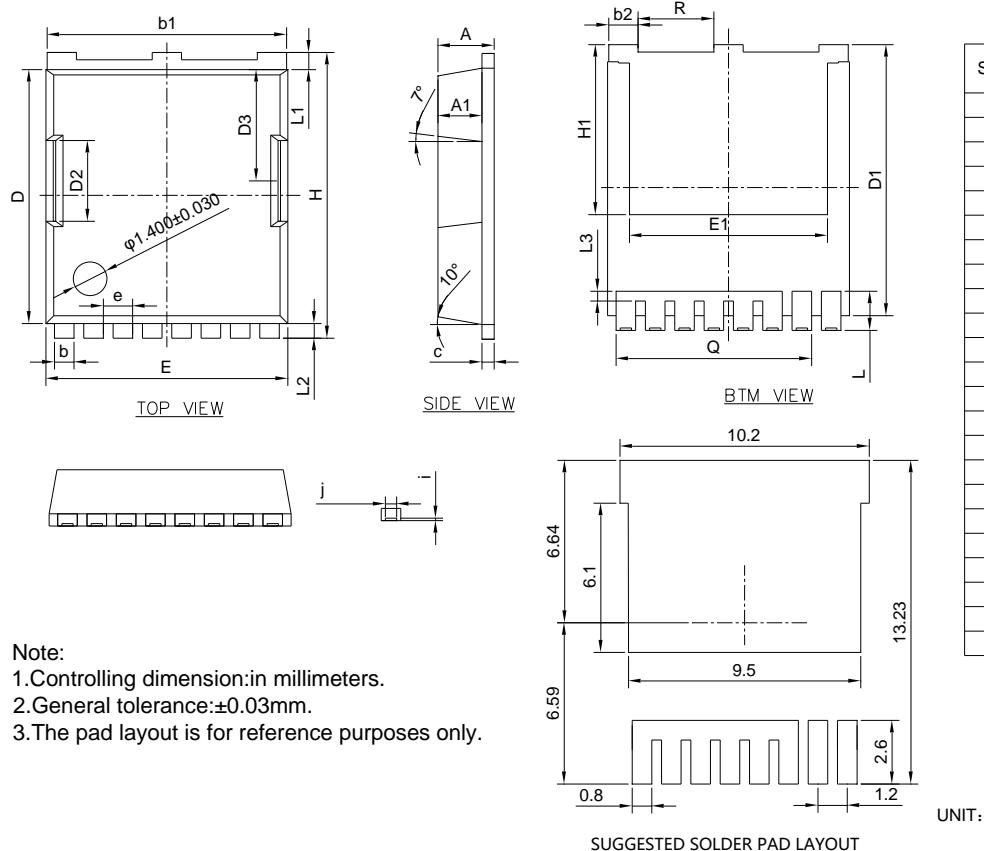


Figure D. Diode Recovery Test Circuit & Waveform



■ TOLL Package information



Note:

1. Controlling dimension:in millimeters.
2. General tolerance: $\pm 0.03\text{mm}$.
3. The pad layout is for reference purposes only.



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